


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588331	<b>Applicant(s)/Patent Under Reexamination</b>  HAYASHI ET AL.
	<b>Examiner</b>  Hannah Pak	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
324	754, 754, 761	9/25/2008	/HP/
81	59.1	9/25/2008	/HP/
524	404	9/25/2008	/HP/
376	272	9/25/2008	/HP/
250	518.1, 515.1	9/25/2008	/HP/

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor/Assignee Search on eDAN/PALM/EAST	9/25/2008	/HP/
Google search	9/25/2008	/HP/
IDS search for references	9/25/2008	/HP/
Specification search for references	9/25/2008	/HP/
STIC structure search request	9/25/2008	/HP/
Plus request search	9/25/2008	/HP/
East search (US PAT, US PG PUB, DERWENT, JPO, EPO)	9/25/2008	/HP/
Non patent literature: Machine translation of japanese documents	9/25/2008	/HP/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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